



SANYO Semiconductors

DATA SHEET

N-Channel and P-Channel Silicon MOSFETs

SCH2601 — General-Purpose Switching Device Applications

Features

- The SCH2601 incorporates two elements in the same package which are N-channel MOSFETs, thereby enabling high-density mounting.
- Low ON-resistance.
- High-speed switching.
- 2.5V drive.
- High resistance to damage from ESD (typ 300V) [with a protection diode connected between the gate and source].

Specifications

Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	N-channel	P-channel	Unit
Drain-to-Source Voltage	V _{DSS}		30	-30	V
Gate-to-Source Voltage (*1)	V _{GSS}		10	-10	V
Drain Current (DC)	I _D		0.7	-0.4	A
Drain Current (Pulse)	I _{DP}	PW≤10μs, duty cycle≤1%	2.8	-1.6	A
Allowable Power Dissipation	P _D	Mounted on a ceramic board (900mm ² ×0.8mm) 1unit	0.65		W
Channel Temperature	T _{ch}		150		°C
Storage Temperature	T _{stg}		-55 to +150		°C

(*1) : Note, when designing a circuit using this product, that it has a gate (oxide film) protection diode connected only between its gate and source.

Electrical Characteristics at Ta=25°C

Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	
[N-channel]						
Drain-to-Source Breakdown Voltage	V(BR)DSS	I _D =1mA, V _{GS} =0V	30			V
Zero-Gate Voltage Drain Current	I _{DSS}	V _D =30V, V _{GS} =0V			1	μA
Gate-to-Source Leakage Current	I _{GSS}	V _{GS} =8V, V _D =0V			1	μA
Cutoff Voltage	V _{GS(off)}	V _D =10V, I _D =100μA	0.4		1.3	V
Forward Transfer Admittance	y _{fs}	V _D =10V, I _D =350mA	0.48	0.8		S
Static Drain-to-Source On-State Resistance	R _{D(on)1}	I _D =350mA, V _{GS} =4V		0.7	0.9	Ω
	R _{D(on)2}	I _D =200mA, V _{GS} =2.5V		0.8	1.15	Ω
	R _{D(on)3}	I _D =10mA, V _{GS} =1.5V		1.6	2.4	Ω

Marking : FA

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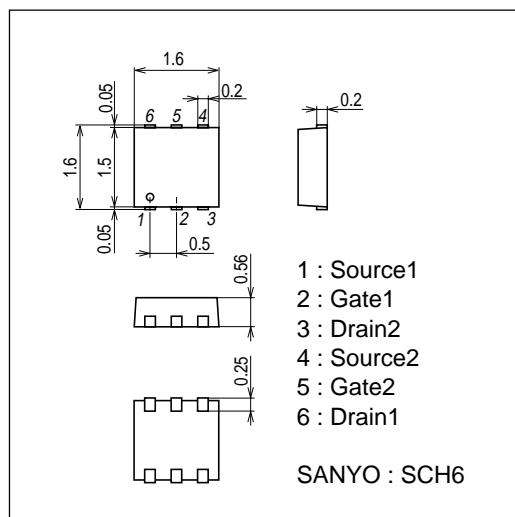
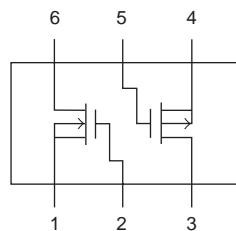
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Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	
Input Capacitance	C _{iss}	V _D S=10V, f=1MHz		30		pF
Output Capacitance	C _{oss}	V _D S=10V, f=1MHz		7		pF
Reverse Transfer Capacitance	C _{rss}	V _D S=10V, f=1MHz		3.5		pF
Turn-ON Delay Time	t _{d(on)}	See specified Test Circuit.		8		ns
Rise Time	t _r	See specified Test Circuit.		6		ns
Turn-OFF Delay Time	t _{d(off)}	See specified Test Circuit.		10		ns
Fall Time	t _f	See specified Test Circuit.		8		ns
Total Gate Charge	Q _g	V _D S=10V, V _G S=4V, I _D =700mA		1		nC
Gate-to-Source Charge	Q _{gs}	V _D S=10V, V _G S=4V, I _D =700mA		0.4		nC
Gate-to-Drain "Miller" Charge	Q _{gd}	V _D S=10V, V _G S=4V, I _D =700mA		0.2		nC
Diode Forward Voltage	V _{SD}	I _S =700mA, V _G S=0V		0.93	1.2	V
[P-channel]						
Drain-to-Source Breakdown Voltage	V(BR)DSS	I _D =-1mA, V _G S=0V	-30			V
Zero-Gate Voltage Drain Current	I _{DSS}	V _D S=-30V, V _G S=0V			-1	μA
Gate-to-Source Leakage Current	I _{GSS}	V _G S=8V, V _D S=0V			-1	μA
Cutoff Voltage	V _G (off)	V _D S=-10V, I _D =-100μA	-0.4		-1.4	V
Forward Transfer Admittance	y _{fs}	V _D S=-10V, I _D =-0.2A	0.25	0.42		S
Static Drain-to-Source On-State Resistance	R _D S(on)1	I _D =-200mA, V _G S=-4V		1.5	1.9	Ω
	R _D S(on)2	I _D =-100mA, V _G S=-2.5V		2.0	2.8	Ω
	R _D S(on)3	I _D =-10mA, V _G S=-1.5V		4.0	8.0	Ω
Input Capacitance	C _{iss}	V _D S=-10V, f=1MHz		40		pF
Output Capacitance	C _{oss}	V _D S=-10V, f=1MHz		8		pF
Reverse Transfer Capacitance	C _{rss}	V _D S=-10V, f=1MHz		4.5		pF
Turn-ON Delay Time	t _{d(on)}	See specified Test Circuit.		10		ns
Rise Time	t _r	See specified Test Circuit.		5		ns
Turn-OFF Delay Time	t _{d(off)}	See specified Test Circuit.		10		ns
Fall Time	t _f	See specified Test Circuit.		5		ns
Total Gate Charge	Q _g	V _D S=-10V, V _G S=-4V, I _D =-0.4A		0.83		nC
Gate-to-Source Charge	Q _{gs}	V _D S=-10V, V _G S=-4V, I _D =-0.4A		0.25		nC
Gate-to-Drain "Miller" Charge	Q _{gd}	V _D S=-10V, V _G S=-4V, I _D =-0.4A		0.17		nC
Diode Forward Voltage	V _{SD}	I _S =-0.4A, V _G S=0V		-1.0	-1.5	V

Package Dimensions

unit : mm

7028-006

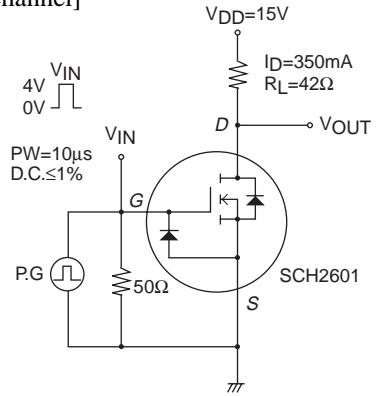
**Electrical Connection**

1 : Source1
2 : Gate1
3 : Drain2
4 : Source2
5 : Gate2
6 : Drain1

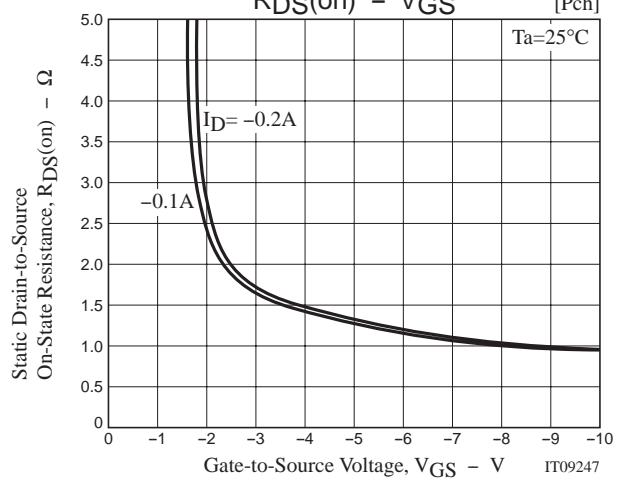
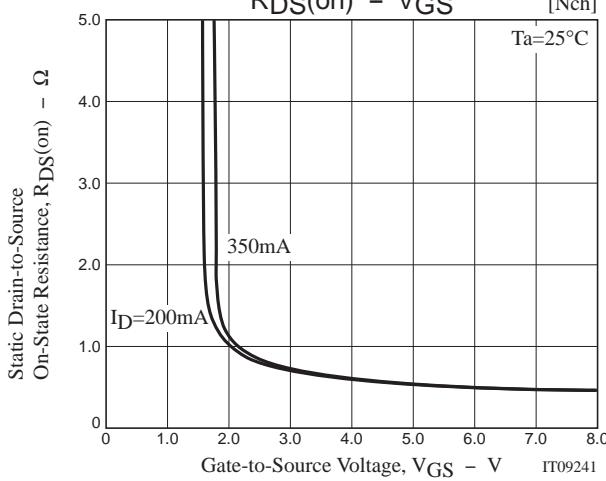
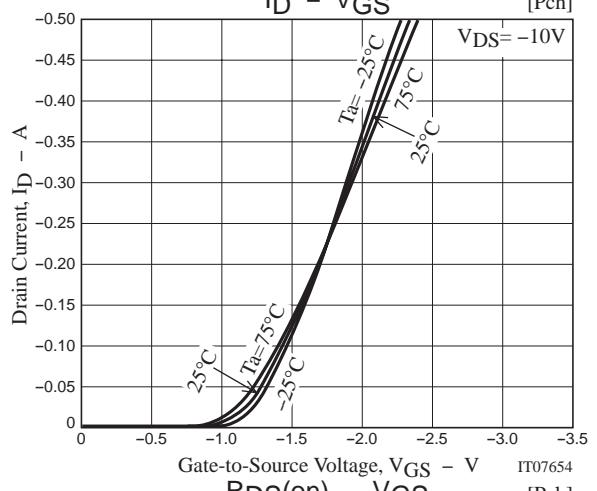
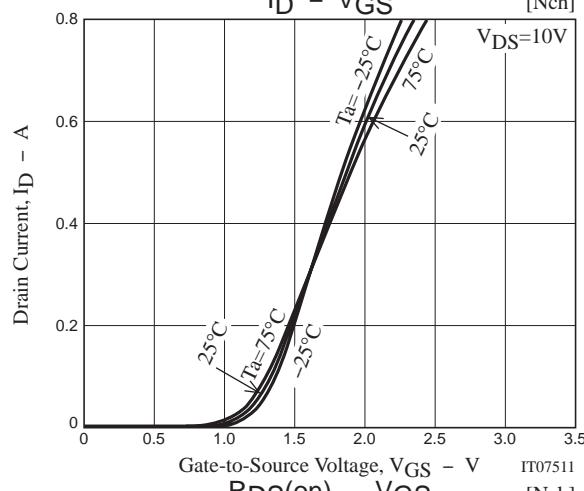
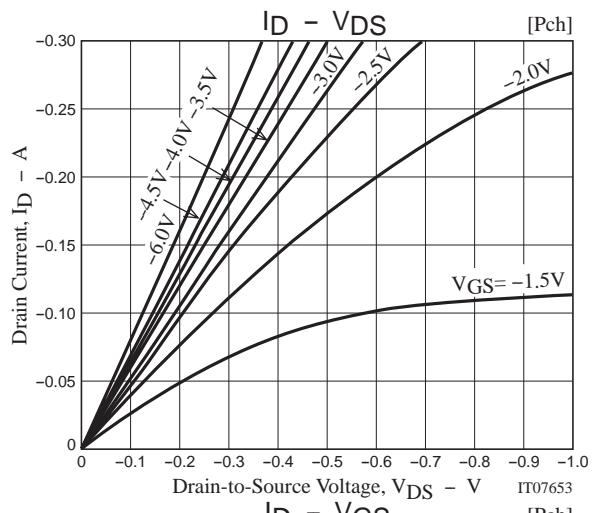
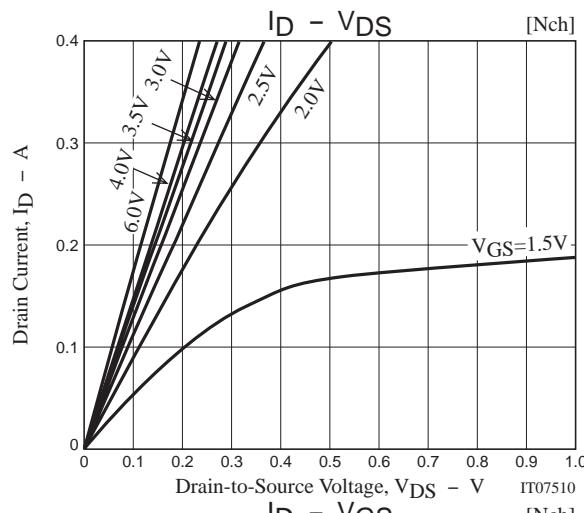
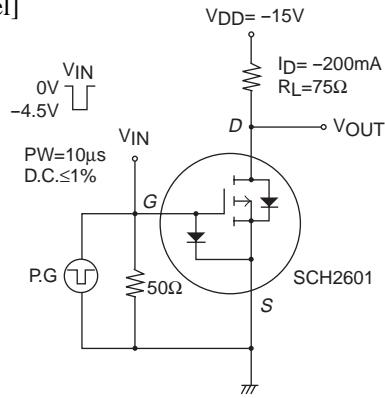
Top view

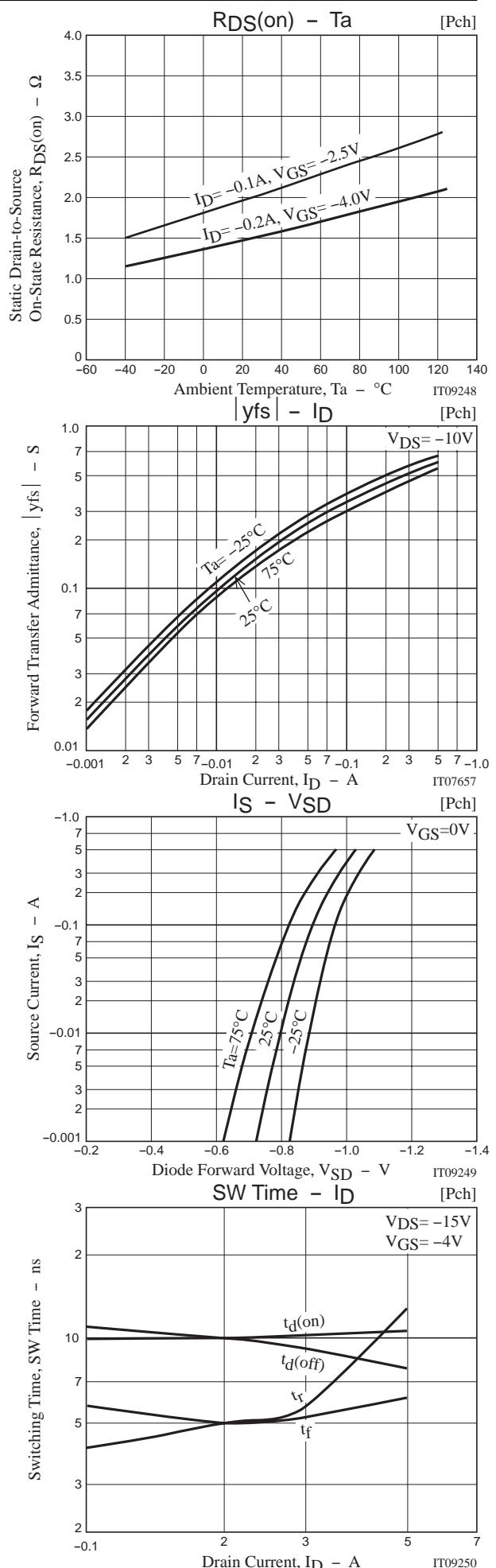
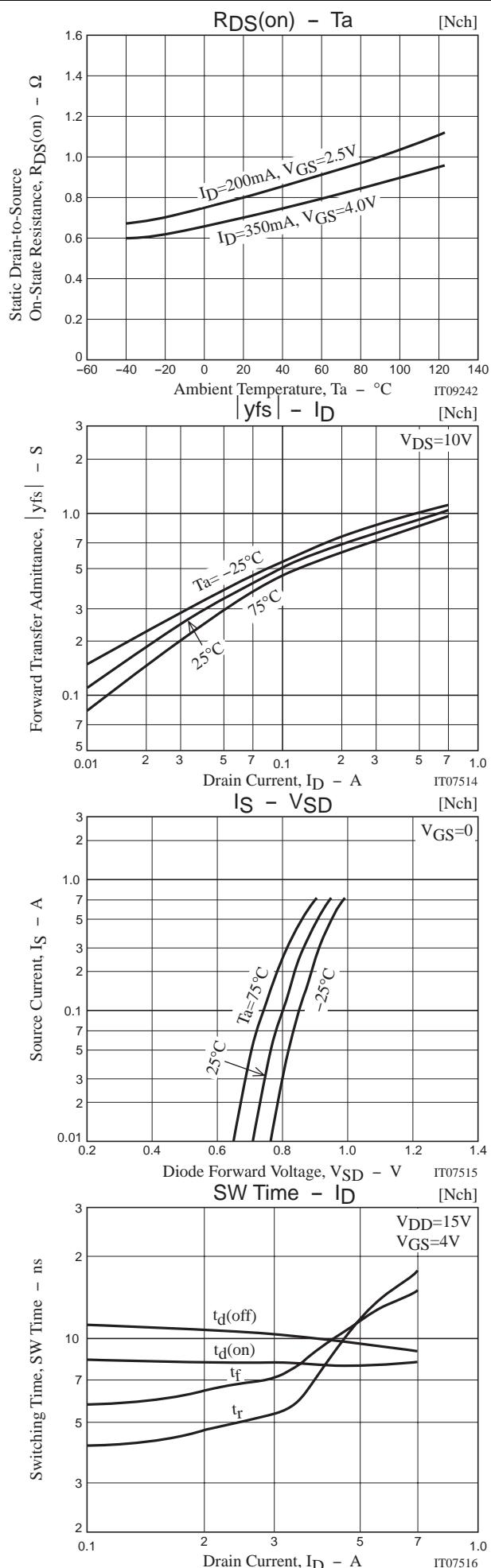
Switching Time Test Circuit

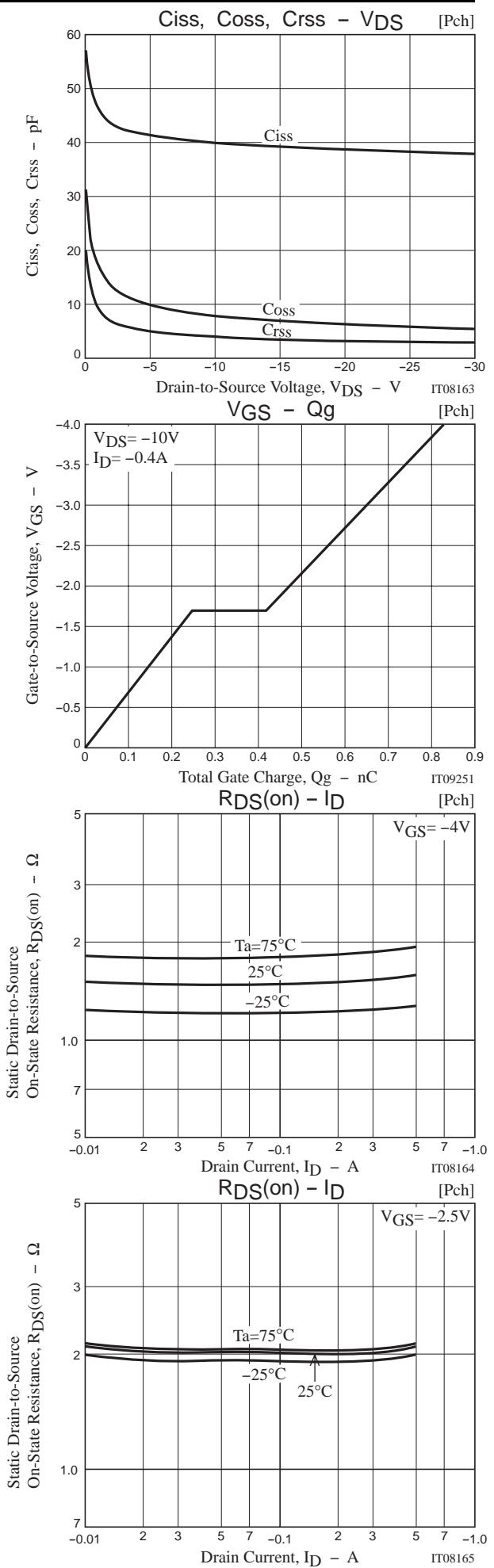
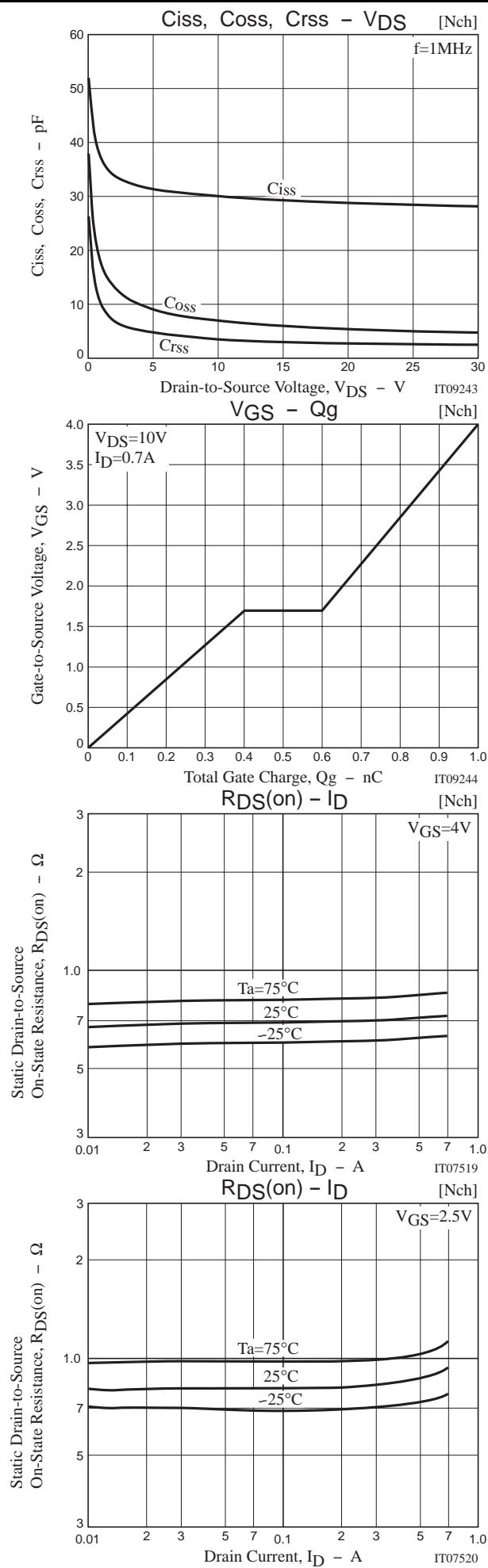
[N-channel]

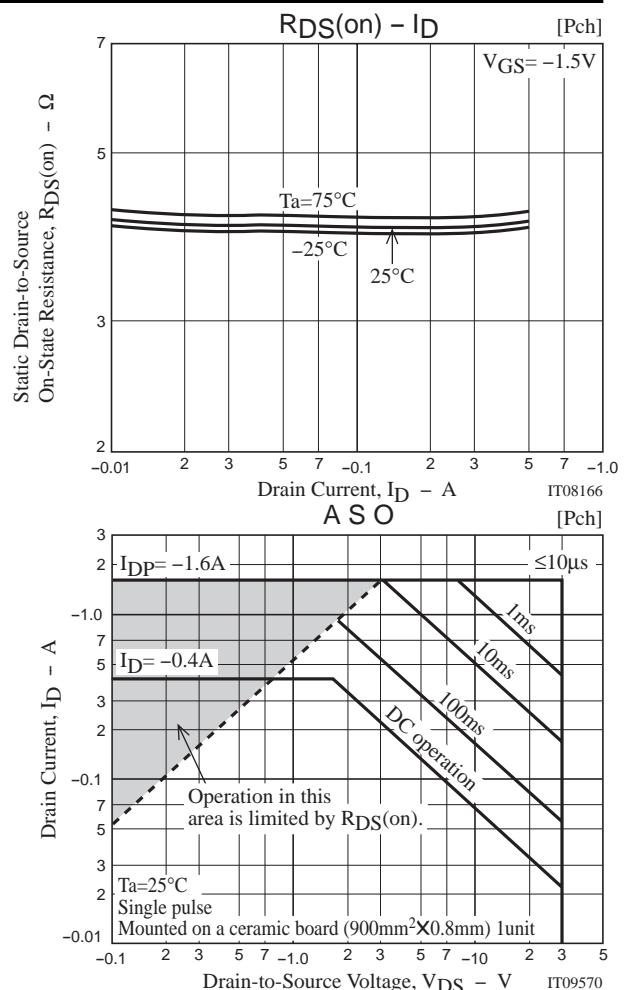
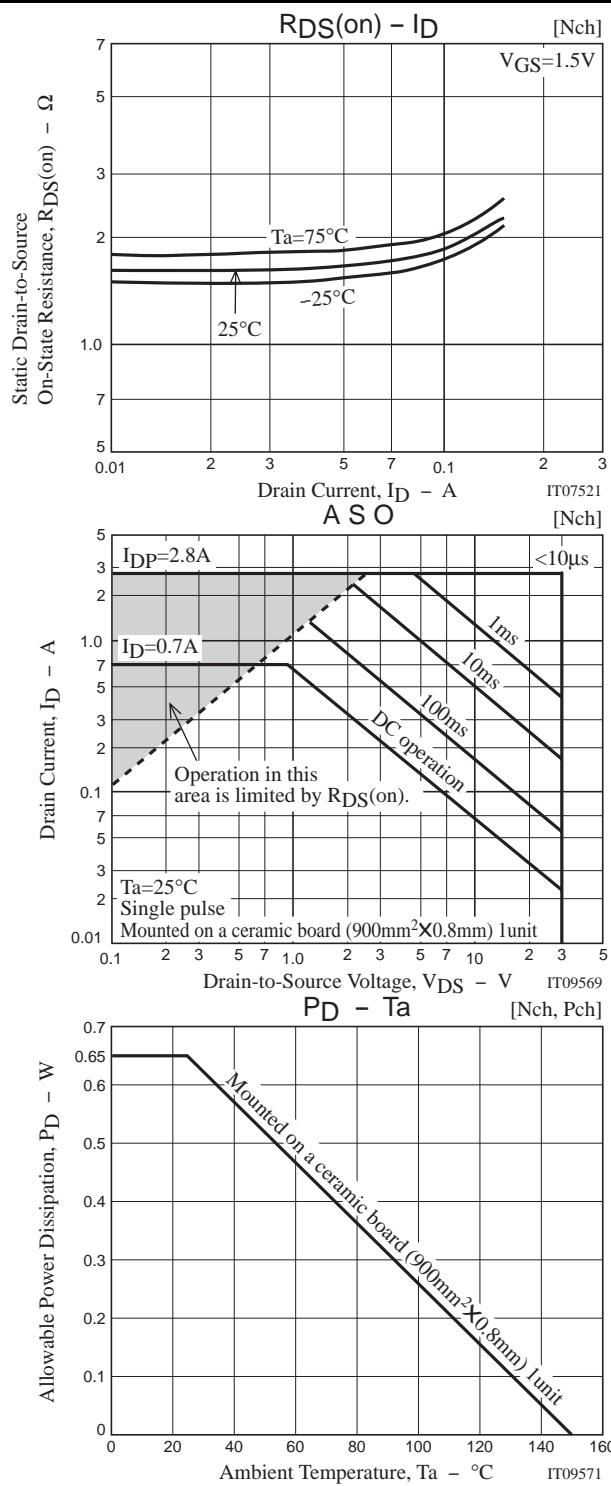


[P-channel]









Note on usage : Since the SCH2601 is a MOSFET product, please avoid using this device in the vicinity of highly charged objects.

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